

More Precision

interferoMETER // High precision absolute interferometers



Absolute distance measurements with nanometer resolution interferoMETER 5400-DS

Absolute measurement with nanometer resolution	r
Compact and robust sensors with larg offset distance	е
$\begin{tabular}{ c c c c } \hline \end{tabular} Measuring rate up to 6 kHz for high sp measurements \end{tabular}$	eed
Ethernet / EtherCAT / RS422 / PROFINE FACE EtherNet/IP	ET /
Robust controller with passive cooling	
Easy configuration via web interface	
Flexible industrial integration	



Absolute distance measurements with nanometer resolution

The IMS5400-DS absolute interferometer opens up new perspectives in industrial distance measurements. The controller has an intelligent evaluation feature and enables absolute measurements with nanometer resolution at a relatively large offset distance. Compared to other absolute measuring optical systems, the IMS5400-DS offers an unsurpassed combination of accuracy, measuring range and offset distance.

Small light spot for the smallest of details and structures

The sensors generate a small light spot over the entire measuring range. The light spot diameter is only 10 μ m in the mid of the measuring range

and enables the detection of small details, for example structures on semiconductors and miniature electronic components.

Absolute measurement of step profiles

Unlike interferometers based on relative measurements, the IMS5400-DS also enables the measurement of step profiles. Thanks to the absolute measurement, the scanning is performed with high signal stability and precision. When measuring on moving objects, the differences in height of heels, steps and depressions can thus be reliably detected.



Controller

Model		IMS5400-DS	IMS5400MP-DS	
Resolution [1]		< 1 nm		
Measuring rate		continuously adjustable	e from 100 Hz to 6 kHz	
Linearity [2]		< ±50 nm	$< \pm 50$ nm for the first distance; $< \pm 150$ nm for each further distance	
Temperature stability	/	temperature compensated, stability < 10 ppm between +15 +35 $^\circ C$		
Multi-peak measure	ment		up to 13 layers	
Light source		NIR-SLED, narrow wavelength band at approx. 84	40 nm; pilot laser: laser LED, wavelength 635 nm	
Laser class		Class 1 according to DIN EN 60825-1: 2015	i-07; Pilot laser: Class 1, power (< 0.2 mW)	
Supply voltage		24 VDC	±15 %	
Power consumption		approx. 10 W (24 V)		
Signal input		Sync in, trigger in, 2x encoders (A+, A-, B+, B-, index)		
Digital interface		Ethernet / EtherCAT / RS422 / PROFINET ^[3] / EtherNet/IP ^[5]		
Analog output		4 20 mA / 0 10 V (16 bit D/A converter)		
Switching output		Error1-Out, Error2-Out		
Digital output		sync out		
	Optical	Pluggable fiber optic cable via E2000 socket (bending radius: static 3	,, · · · · · · · · · · · · · · · · · ·	
Connection	Electrical	3-pin supply terminal strip; encoder connection (15-pin, HD-sub so RS422 connection socket (9-pin, Sub-D, max. cable length 3 11-pin I/O terminal strip (max. cable length 30 m); RJ45 socket	30 m); 3-pin output terminal strip (max. cable length 30 m);	
Mounting		Free-standing, D	IN rail mounting	
T	Storage	-20 +	+70 °C	
Temperature range	Operation	+15	+35 °C	
Shock (DIN EN 6006	68-2-27)	15 g / 6 ms in XY axis, 1000 shocks each		
Vibration (DIN EN 60068-2-6)		2 g / 20 500 Hz in XY axis, 10 cycles each		
Protection class (DIN EN 60529)		IP4	40	
Material Control and indicator elements		Aluminum housing	g, passive cooling	
		Multifunction button: two adjustable functions and reset to factory settings after 10 s; web interface for setup: selectable presets, freely selectable averaging, data reduction, setup management; 6 x color LEDs for intensity, range, SLED, pilot laser, status and power; pilot laser: can be switched on for sensor alignment		

^[1] All data at constant ambient temperature (24 ±2 °C). Measuring rate 0.5 kHz, moving average over 64 values, measured differentially between the front and back of a thin glass plate in the mid of the measuring range (2 sigma) ^[2] Maximum deviation from reference system over the entire measuring range, measured on front surface of ND filter

^[3]Optional connection via interface module (see accessories)

Sensors for distance measurements interferoMETER 5400-DS/5600-DS



Sensors for the IMS5400 / IMS5600 controllers for distance measurement

Model		IMP DS1/VAC	IMP DS0.5/90/VAC	IMP DS10/90/VAC	IMP DS19
	Distance	1 mm	1.5 mm	1.5 mm	2.1 mm
Measuring range	Thickness [1]	0.01 0.7 mm	0.01 1.0 mm	0.01 1.0 mm	0.01 1.3 mm
Start of measuring rang	ge	1 mm	0.5 mm	10 mm	19 mm
Temperature stability		Linearity: typ. 0.1 nm / K (without offset shift) 10 μ m			
Light spot diameter [2]					
Measuring angle [3]			±2°		
Target material		Glass, reflecting or diffuse surfaces [4]			
Connection	Optical	Sensor with integrated vacuum optical fiber; length 2 m and FC/APC connector. Extension via pluggable optical fiber FC socket (vacuum feedthrough); cable lengths see accessories; bending radius: static 30 mm, dynamic 40 mm	Pluggable fiber optic cable via FC socket (vacuum feedthrough); pluggable UHV fiber optic cable via FC socket (feedthrough and sensor with vacuum capability); cable lengths see accessories; bending radius: static 30 mm, dynamic 40 mm		
Mounting		Radial clamping, mounting adapter (see accessories)			
Temperature range	Storage	-20 +70 °C			
lemperature range	Operation	+5 +70 °C			
Dimensions	Diameter	Ø4	Ø10	Ø10	Ø10
DIMENSIONS	Length	23 mm	approx. 78.1 mm	approx. 68.6 mm	55 mm
Protection class (DIN EN 60529) Vacuum Material		IP40	IP40	IP40	IP65; IP40 (option/VAC
		UHV (cable and sensor)	UHV (cable and sensor)	UHV (cable and sensor)	Optional UHV (cable and sensor)
		Stainless steel; optional: titanium housing	Stainless steel	Stainless steel; optional: titanium housing	Stainless steel; optiona titanium housing

^[1] Application for MP measurement

 $^{[2]}\mbox{All}$ data at constant ambient temperature (24 ± 2 °C). In the mid of the measuring range

^[3] Maximum sensor tilt angle that produces a usable signal on polished glass (n = 1.5) in the mid of the measuring range. The accuracy decreases when approaching the limit values.

^[4] Non-transparent materials require optically dense surface at a wavelength of 840 nm

Dimensions

IMS5400-DS / IMS5600-DS controller





Distance sensor IMP DS1/VAC





Connection possibilities interferoMETER

Connection options for the IMS5400 and IMS5600 controllers



Connection options for the IMS5420 controller



FC/APC Standard connector

E2000/APC Standard connector



Article designations

IMS5xxx-DSxx distance measuring system (e.g. IMS5600MP-DS19)

IMS5xxx		-DSxx	
	Controller model	Sensor model	
	IMS5400	DS1/VAC	
	IMS5400MP	DS19	
	IMS5600	DS19/VAC	
	IMS5600MP	DS0.5/90/VAC	
		DS10/90/VAC	



IMS5xxx-THxx thickness measuring system (e.g. IMS5400-TH45/VAC)

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IMS5xxx		-THxx
Controller	model	Sensor model
IMS5400		TH45
IMS5400M	D	TH45/VAC
		TH70

IMS5420xx-THxx wafer thickness measuring system (e.g. IMS5420-TH24)

IMS5xxx	-THxx
Controller model	Sensor model
IMS5420	TH24
IMS5420MP	TH24(204)
IMS5420IP67	
IMS5420IP67MP	

Optional accessories interferoMETER

Flange for vacuum feedthrough

C5405/VAC/1/CF16 CF flange C5405/VAC/1/KF16 KF flange

Mounting adapter

MA5400- 10	Mounting adapter for IMP-DS19/ -TH45
MA5400- 20	Mounting adapter for IMP-TH70
MA2402-4	Mounting adapter for IMP-DS1

Other accessories

SC2471-x/IF2008	IMC5400/5600 connector cable+ IF2008/PCIE, length 3 m / 10 m	
SC2471-x/RS422/OE	IMC5400/5600 interface cable + IF2001/USB, length 3 m / 10 m	
IF2001/USB	RS422/USB converter	
IF2008/PCIE	Interface card	
IF2035/PNET	Interface module for PROFINET integration	
IF2035-EIP	Interface module for EtherNet/IP with DIN rail housing	
PS2020	Power supply 24V / 2.5A	
EC2471-3/OE	Encoder cable, 3 m	



C5405/VAC/1/CF16 C5405/VAC/1/KF16

Sensor mounting adapter

MA5400-10

Sensor mounting adapter for all interferoMETER sensors: (exception IMP-DS1, IMP-TH70)





MA5400-20

Sensor mounting adapter for IMP-TH70 sensors:



MA2402-4

Sensor mounting adapter for IMP-DS1 sensors



Adjustable mounting adapter

The adjustable JMA mounting adapter simplifies the alignment and fine adjustment of interferometric sensors. The sensors and adapters can be integrated into the machine and aligned directly on site. This corrects, e.g, minor deviations caused by mounting and compensates for tilted measuring objects. With two-sided thickness measurements, the mounting adapter supports the fine alignment of the two measuring points.



Sensor holder

Sensor holder for JMA-10



Sensor holder for JMA-20

 $\alpha 20.05 \stackrel{+0.05}{-0}$



(dimensions in mm, not to scale)

ø27

19.8 -0.5

A-A

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